Search Notes

Application/Control No.	App
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plicant(s)/Patent under examination UENO, TOSHIHARU Art Unit

09/769,513

Examiner

Yogesh K. Aggarwal

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INT	ERFERENC	E SEARCH	ED
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Interferen	ce search	1/7/2007	YKA

SEARCH NOT (INCLUDING SEARCH :)
	DATE	EXMR
348/333.01,333.11,333.012,333.06,33 3.07,345,346,335,340,220.1,222.1,22 3.1,229.1,362;396/81,84	1/7/2007	YKA
Inventor search	1/7/2007	· YKA
Tuan Ho, Vivek Srivastava	1/4/2007	YKA
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